

**Search Notes**

Application/Control No.

09/382,375

Examiner

Hai V. Nguyen

Applicant(s)/Patent under  
Reexamination

PHILYAW ET AL.

Art Unit

2142

**SEARCHED**

Class	Subclass	Date	Examiner
709	217	5/3/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search Updated	5/3/2005	HN